

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 22380-014US1	Application No. 10/551,203
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant <i>West et al.</i>	
		Filing Date June 29, 2006	Group Art Unit 1615

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/SM/	AA	2004/253318	12/16/2004	West et al.			
/SM/	AB	2004/067890	04/18/2004	Gupta			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/SM/	AL	2004/091636	10/28/2004	WIPO				
/SM/	AM	2002/40034	05/23/2002	WIPO				
/SM/	AN	2003/013550	02/20/2003	WIPO				
/SM/	AO	2003/026673	04/03/2003	WIPO				
/SM/	AP	8073338	03/19/1996	Japan			Abstract	

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
/SM/	AQ	European Patent Office, <i>Supplementary European Search Report</i> , Application No. 050706340.6-2123 PCT/AU2005000307, March 7, 2007, 5 pages.
	AR	
	AS	
	AT	

Examiner Signature <i>/Snigdha Maewall/</i>	Date Considered 06/12/2007
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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(MODIFIED) U.S. PATENT AND TRADEMARK OFFICE



INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

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APPLICANT

WEST et al.

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September 27, 2005

GROUP

(Not yet assigned)

U.S. PATENT DOCUMENTS

Examiner Initial	Cite No. ¹	Patent Number	Issue Date	Patentee	Class/ Subclass	Filing Date
<u>Sm</u>		6384043	5/2002	Peyman et al.		

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

Examiner Initial	Document Number	Publication Date	Country or Patent Office	Class/ Subclass	Translation Yes/No
<u>Sm</u>	2004/014432	2/2004	WO		
<u>I</u>	2003/024429	3/2003	WO		
<u>J</u>	2003/024430	3/2003	WO		
<u>Sm</u>	JP 025-201858	8/1993	JP		abstract only

OTHER DOCUMENTS

(Including Author, Title, Date, Relevant Pages, Place of Publication)

Examiner Initial	Cite No. ¹	

EXAMINER	DATE CONSIDERED
<u>S. Maxwell</u>	<u>08/31/07</u>

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